

## APL502B2(G) APL502L(G)

### 500V 58A 0.090Ω

# LINEAR MOSFET

Linear Mosfets are optimized for applications operating in the Linear region where concurrent high voltage and high current can occur at near DC conditions (>100 msec).

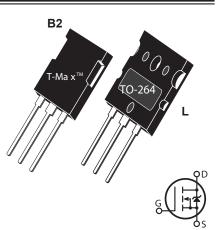
- Higher FBSOA
- Popular T-MAX™ or TO-264 Package
- Higher Power Dissipation
- RoHS Compliant
- MAXIMUM RATINGS

All Ratings:  $T_{C} = 25^{\circ}C$  unless otherwise specified.

Symbol	Parameter	APL502B2_L(G)	UNIT			
V <sub>DSS</sub>	Drain-Source Voltage	500	Volts			
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	58	Amps			
I <sub>DM</sub>	Pulsed Drain Current $^{\textcircled{1}}$	232				
V <sub>GS</sub>	Gate-Source Voltage Continuous	±30	Volts			
V <sub>GSM</sub>	Gate-Source Voltage Transient	±40				
P	Total Power Dissipation @ T <sub>C</sub> = 25°C	730	Watts			
P <sub>D</sub>	Linear Derating Factor	5.84	W/°C			
T <sub>J</sub> ,T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 to 150	°C			
Τ <sub>L</sub>	Lead Temperature: 0.063" from Case for 10 Sec.	300				
I <sub>AR</sub>	Avalanche Current $^{(1)}$ (Repetitive and Non-Repetitive)	58	Amps			
E <sub>AR</sub>	Repetitive Avalanche Energy $^{igitharpi}$	50	— mJ			
E <sub>AS</sub>	Single Pulse Avalanche Energy ④	3000				
STATIC ELECTRICAL CHARACTERISTICS						

Symbol	Characteristic / Test Conditions / Part Number	MIN	TYP	MAX	UNIT
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0V, I <sub>D</sub> = 250 $\mu$ A)	500			Volts
I <sub>D</sub> (ON)	On State Drain Current $^{(2)}(V_{DS} > I_{D}(ON) \times R_{DS}(ON) Max, V_{GS} = 15V)$	58			Amps
R <sub>DS</sub> (ON)	Drain-Source On-State Resistance <sup>(2)</sup> (V <sub>GS</sub> = 15V, 29A)			0.09	Ohms
I <sub>DSS</sub>	Zero Gate Voltage Drain Current ( $V_{DS}$ = 500V, $V_{GS}$ = 0V)			25	μA
	Zero Gate Voltage Drain Current ( $V_{DS}$ = 400V, $V_{GS}$ = 0V, $T_{C}$ = 125°C)			250	
I <sub>GSS</sub>	Gate-Source Leakage Current ( $V_{GS} = \pm 30V, V_{DS} = 0V$ )			±100	nA
V <sub>GS</sub> (TH)	Gate Threshold Voltage $(V_{DS} = V_{GS}, I_{D} = 2.5mA)$	2		4	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



#### **DYNAMIC CHARACTERISTICS**

Symbol	Characteristic	Test Conditions	MIN	ТҮР	MAX	UNIT
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V		7485	9000	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V		1290	1810	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz		617	930	
t <sub>d</sub> (on)	Turn-on Delay Time	V <sub>GS</sub> = 15V		13	26	
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 250V		27	54	ns
t <sub>d</sub> (off)	Turn-off Delay Time	I <sub>D</sub> = 29A @ 25°C		56	84	
t <sub>f</sub>	Fall Time	$R_{g} = 0.6\Omega$		16	20	

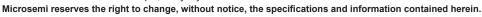
#### **THERMAL CHARACTERISTICS**

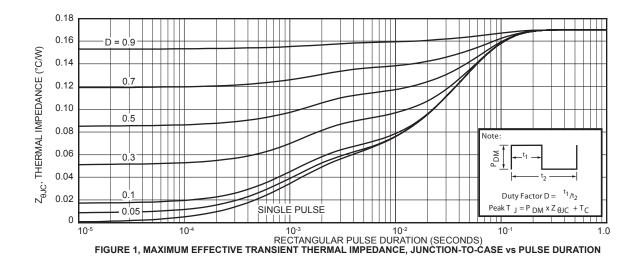
Symbol	Characteristic	MIN	ТҮР	MAX	UNIT
R <sub>θJC</sub>	Junction to Case			.17	°C/W
W <sub>T</sub>	Package Weight		0.22		οz
			5.9		g

 $^{(1)}$  Repetitive Rating: Pulse width limited by maximum junction temperature.

 $\overset{(3)}{=}$  See MIL-STD-750 Method 3471  $\overset{(4)}{=}$  Starting T<sub>i</sub> = +25°C, L = 1.78mH, R<sub>G</sub> = 25\Omega, Peak I<sub>L</sub> = 58A

(2) Pulse Test: Pulse width < 380 µS, Duty Cycle < 2%





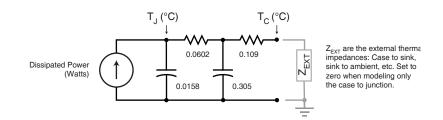
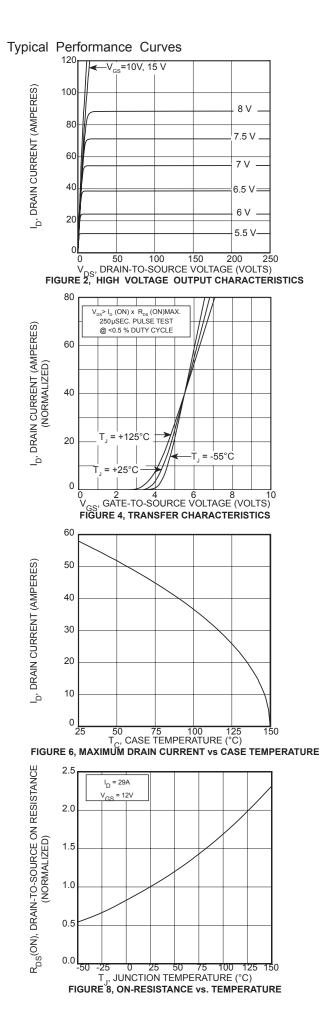
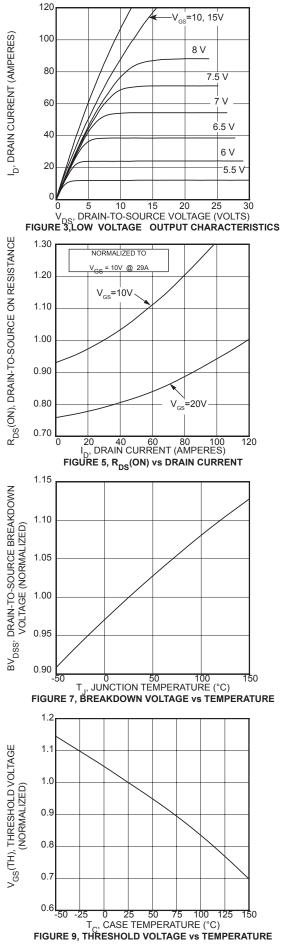
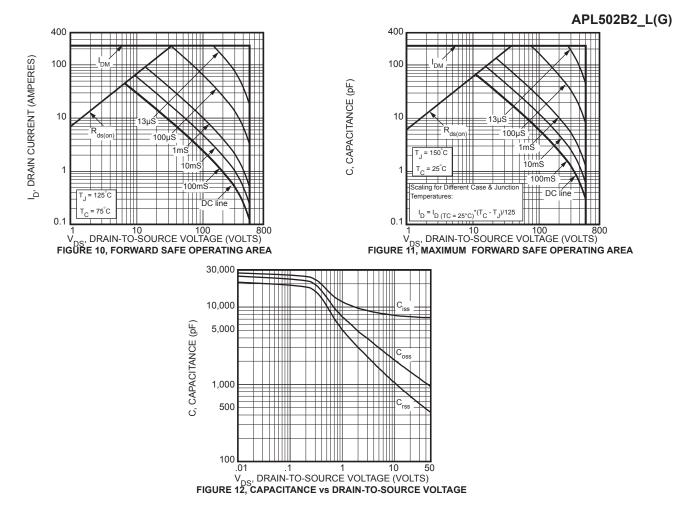


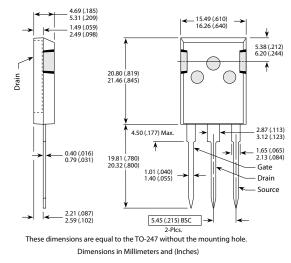
FIGURE 1a, TRANSIENT THERMAL IMPEDANCE MODEL



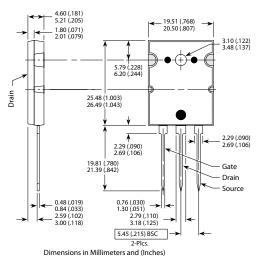




T-MAX<sup>™</sup> (B2) Package Outline



TO-264 (L) Package Outline



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